



# Quadrature Generation Techniques in CMOS Relaxation Oscillators

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# Outline

- Introduction & Motivation
- Quadrature Relaxation Oscillators (QRXO)
  - Shunt-coupled QRXO
  - Series-coupled QRXO
- Design and Simulation Results
- Summary



# Introduction

- RF oscillator: key block in wireless & wireline communication systems [1,2]
- LC VCOs are commonly used
  - Low phase noise (high-Q)
  - Large area (spiral inductors)
  - Tuning range limited by device parasitics
- Quadrature LO signals
  - Recovery of IQ signal
  - Image-rejection



# IQ LO Generation – 1

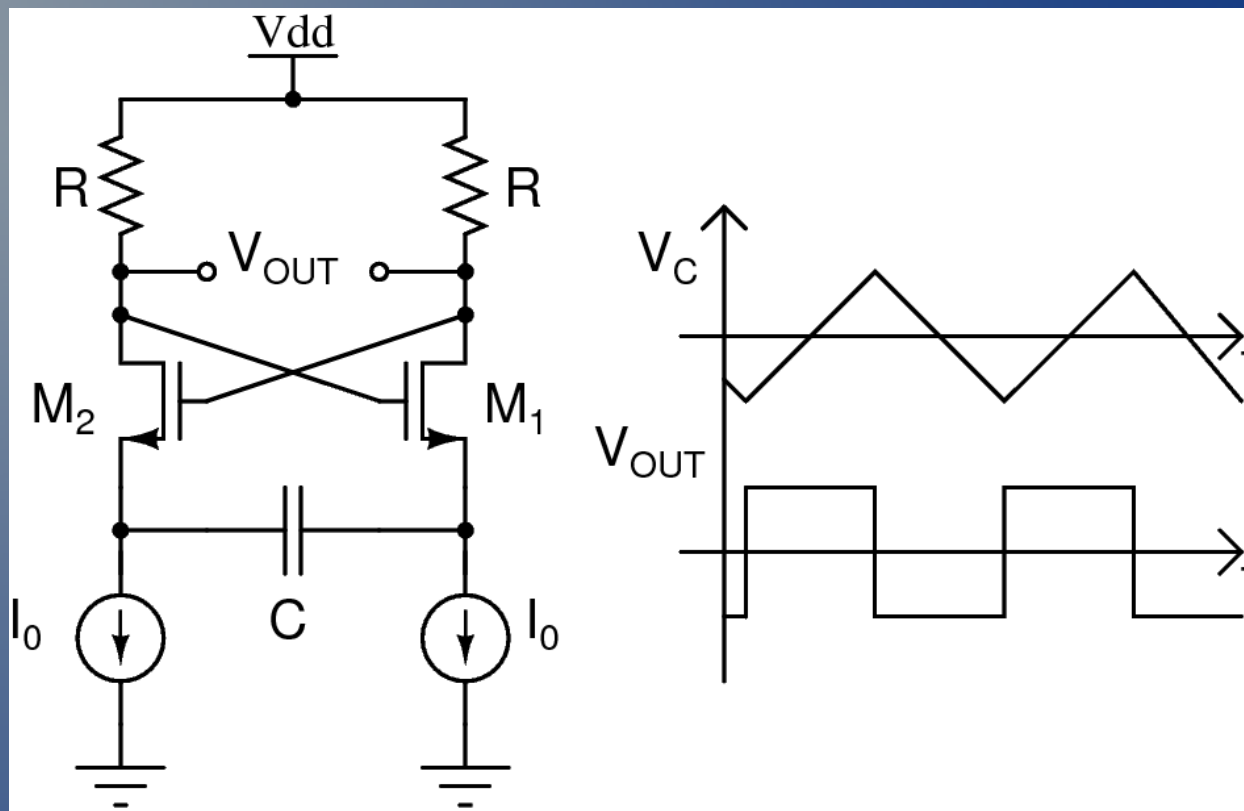
- VCO ( $f_0$ ) + polyphase filter
  - High frequencies: capacitive parasitics become comparable to filter C
  - Buffers required to drive low impedances = high power consumption
  - Quadrature error  $\Leftarrow$  R & C matching
- VCO ( $2f_0$ ) + Divide-by-2
  - LC oscillator potentially has higher Q at  $2f_0$
  - Divider power becomes significant
  - Quadrature error  $\Leftarrow$  device matching



# IQ LO Generation – 2

- Four-stage ring oscillator ( $f_0$ )
  - Tuning range set by stage delays
  - Quadrature error  $\Leftarrow$  delay matching
- Quadrature VCO ( $f_0$ ) [1,3,4]
  - Power efficient at higher frequencies
  - Quadrature error  $\Leftarrow$  coupling strength

# Relaxation Oscillator



- Schmitt Trigger: Cross-coupled NMOS + R loads
- Integrator: Capacitor C
- Tune frequency using  $I_0$

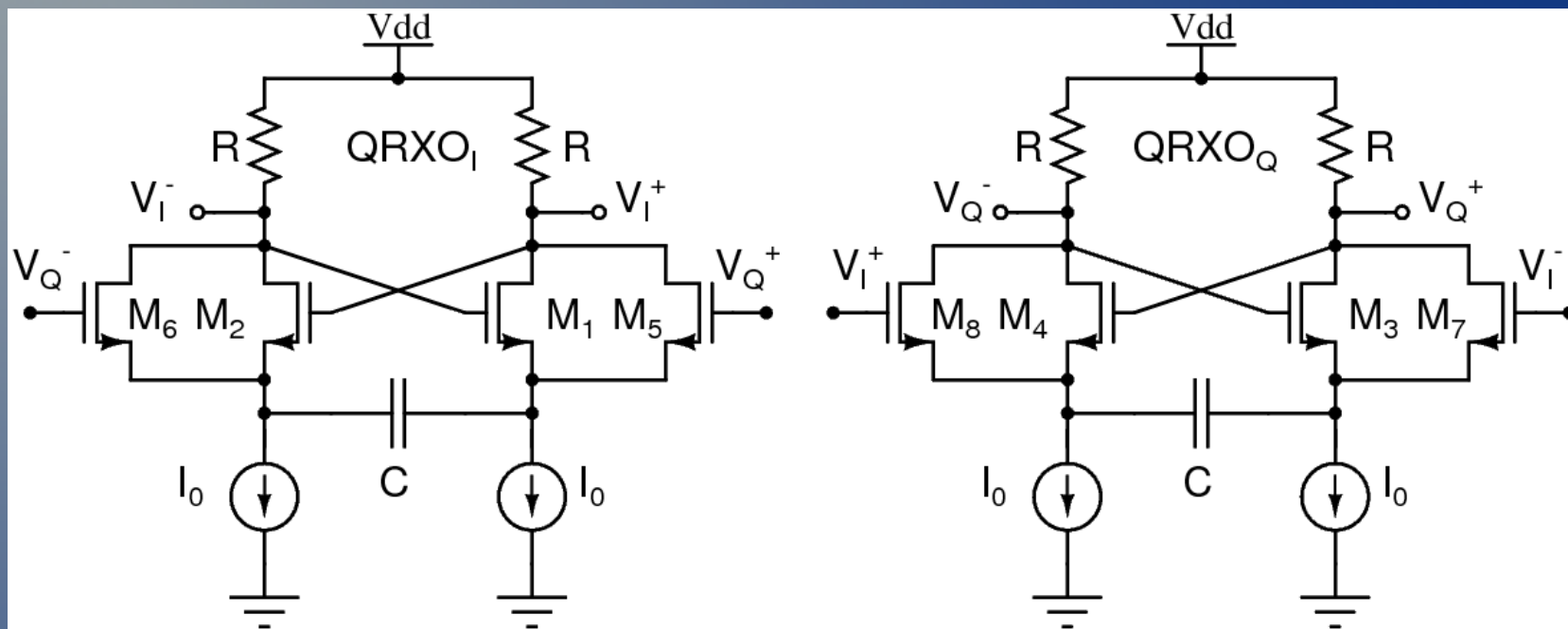


# Quadrature Generation

- Quadrature Relaxation Oscillator [5,6]
  - $V_C$  and  $V_{OUT}$  are  $90^\circ$  out of phase
  - Integrator of each oscillator triggers the other
- Quadrature LC VCO
  - Inhibit negative resistance generation for  $0^\circ$  or  $180^\circ$  modes
  - Shunt & series injection
- Quadrature Relaxation Oscillator (this work)
  - Suppress Schmitt-trigger operation for  $0^\circ/180^\circ$
  - Shunt & Series coupling



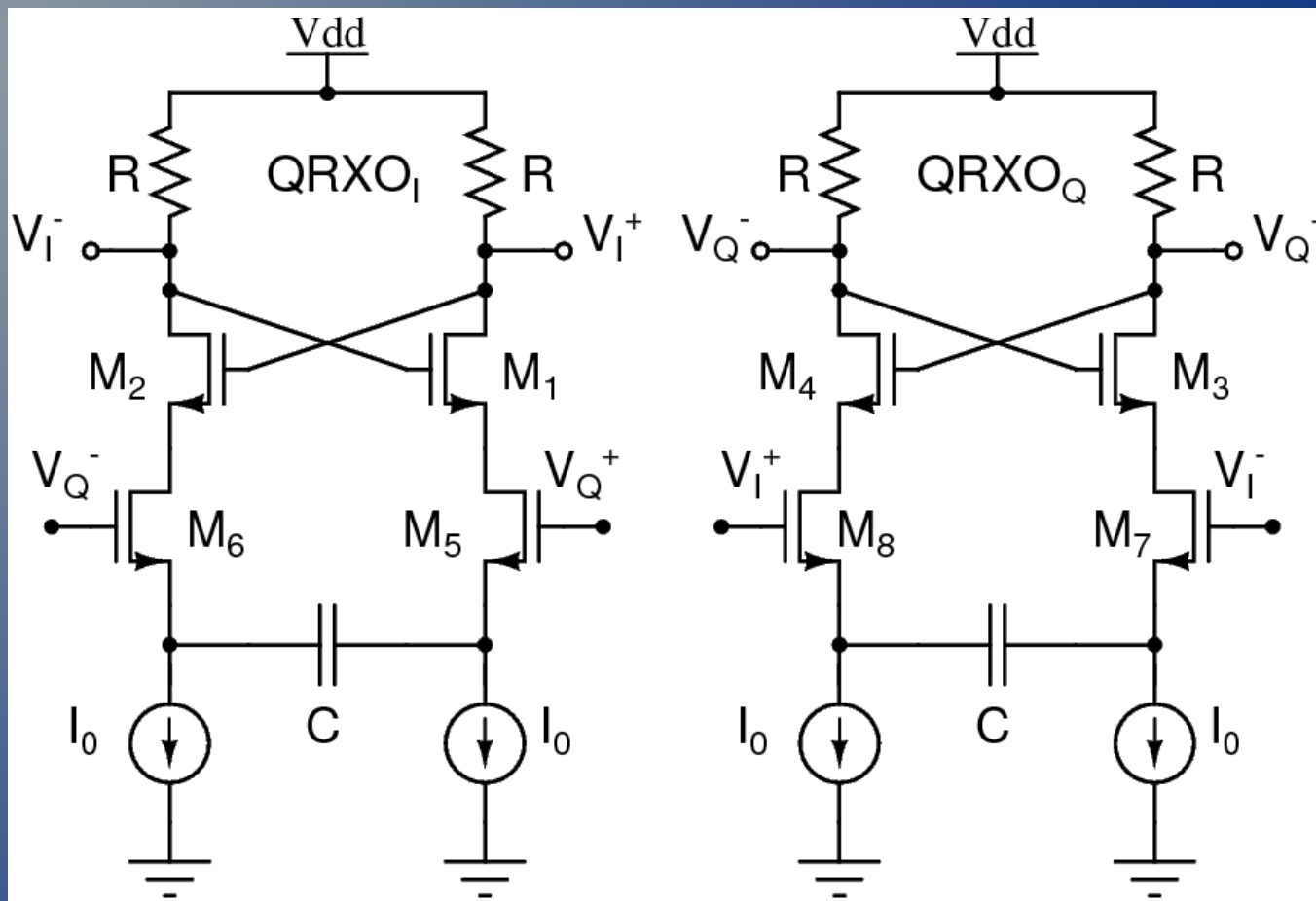
# Shunt Coupled QRXO



- $I=Q$  (in-phase)  $\Rightarrow$   $M_{5-6}$  oppose  $M_{1-2}$ 
  - QRXO<sub>I</sub> dies out  $\Rightarrow$  QRXO<sub>Q</sub> too ceases to oscillate
- $I=\bar{Q}$  (out-of-phase)  $\Rightarrow$   $M_{7-8}$  oppose  $M_{3-4}$ 
  - QRXO<sub>Q</sub> dies out  $\Rightarrow$  QRXO<sub>I</sub> too ceases to oscillate



# Series Coupled QRXO



- Series injection through  $M_{5-8}$
- Coupling devices in triode region

# Circuit Design & Simulation



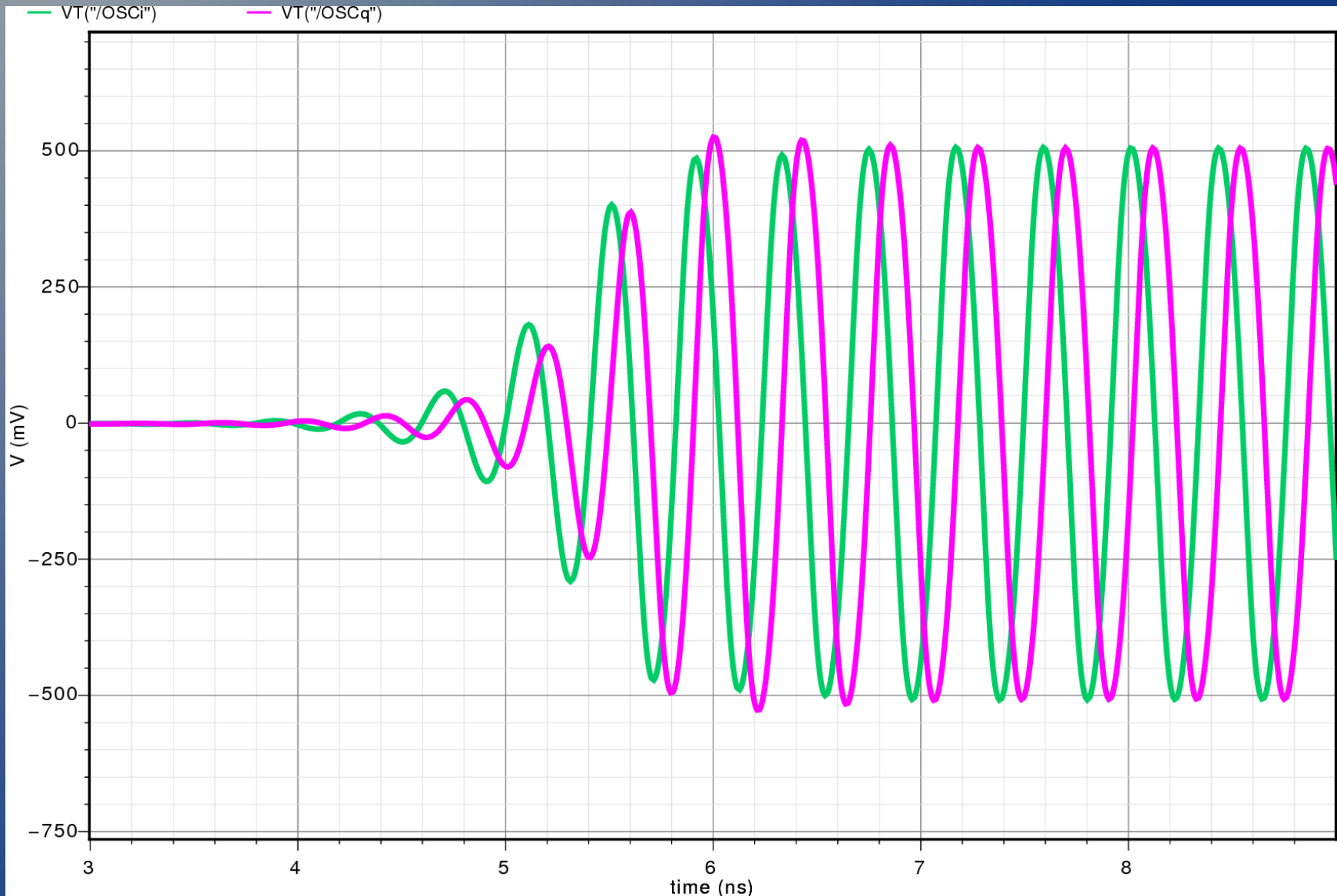
- Quadrature relaxation oscillators designed and simulated using Spectre (Cadence)
  - $f_0 = 2.4\text{GHz}$
  - UMC  $0.18\mu\text{m}$  CMOS process ( $V_{DD} = 1.8\text{V}$ )
- Reference 2.4GHz relaxation oscillator
  - Total bias current = 6mA
  - $M_{1-2} = 100\mu\text{m} \times 0.25\mu\text{m}$
  - Load resistance  $R = 100\Omega$
  - Integrator capacitance  $C = 460\text{fF}$



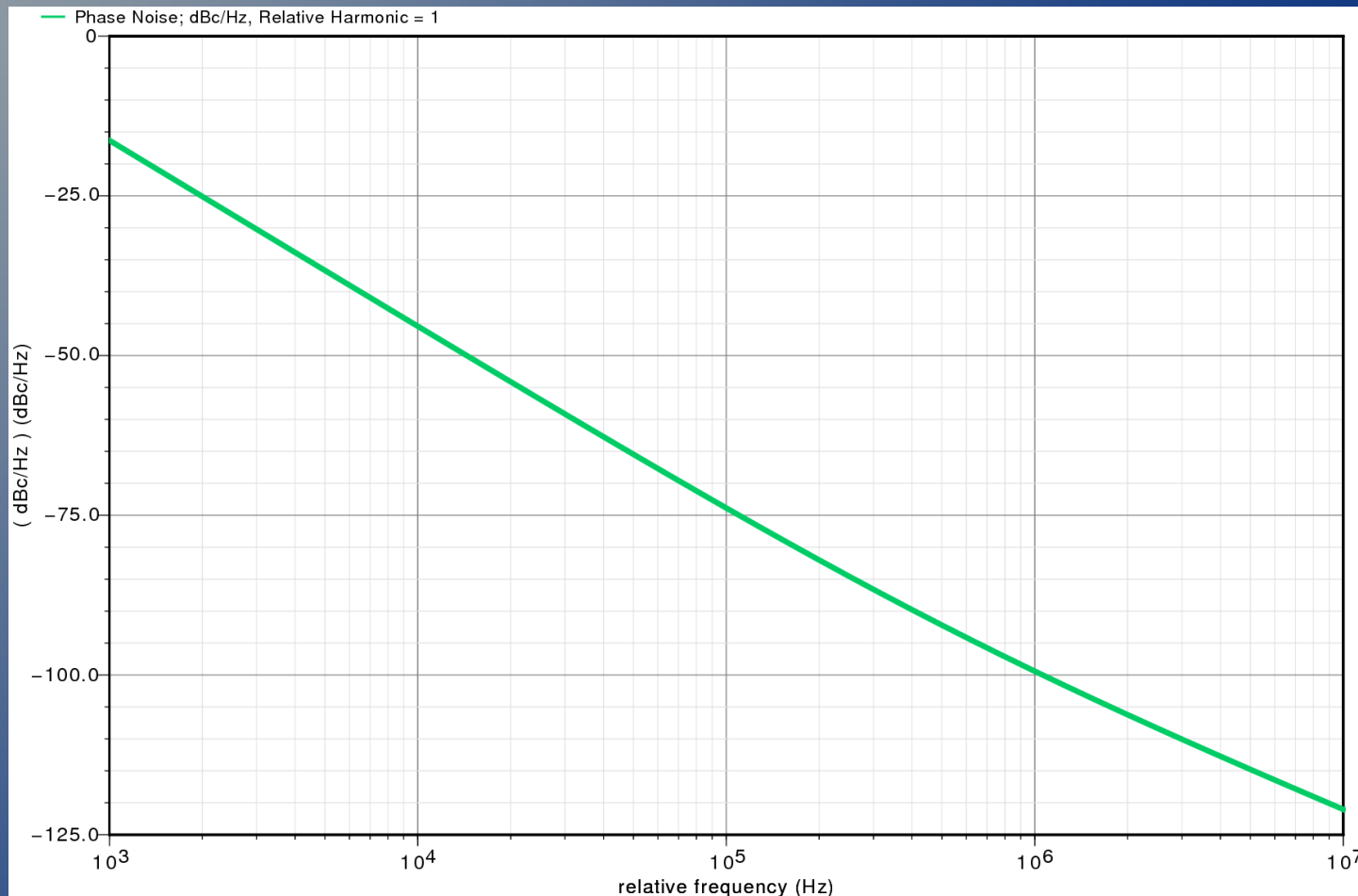
# Shunt-coupled QRXO

- Quadrature coupling validated in simulation
- Primary design parameter: size of quadrature coupling devices
  - Large W/L  $\Rightarrow$  strong coupling, larger parasitics
  - Small W/L  $\Rightarrow$  weak coupling, more flicker noise
  - Larger L  $\Rightarrow$  less flicker noise, more parasitics
  - $M_{5-8} = 36\mu\text{m} \times 0.65\mu\text{m}$
- Total QRXO current = 12mA
- 1% I-Q mismatch  $\Rightarrow$   $0.25^\circ$  quadrature error

# Shunt QRXO – Startup

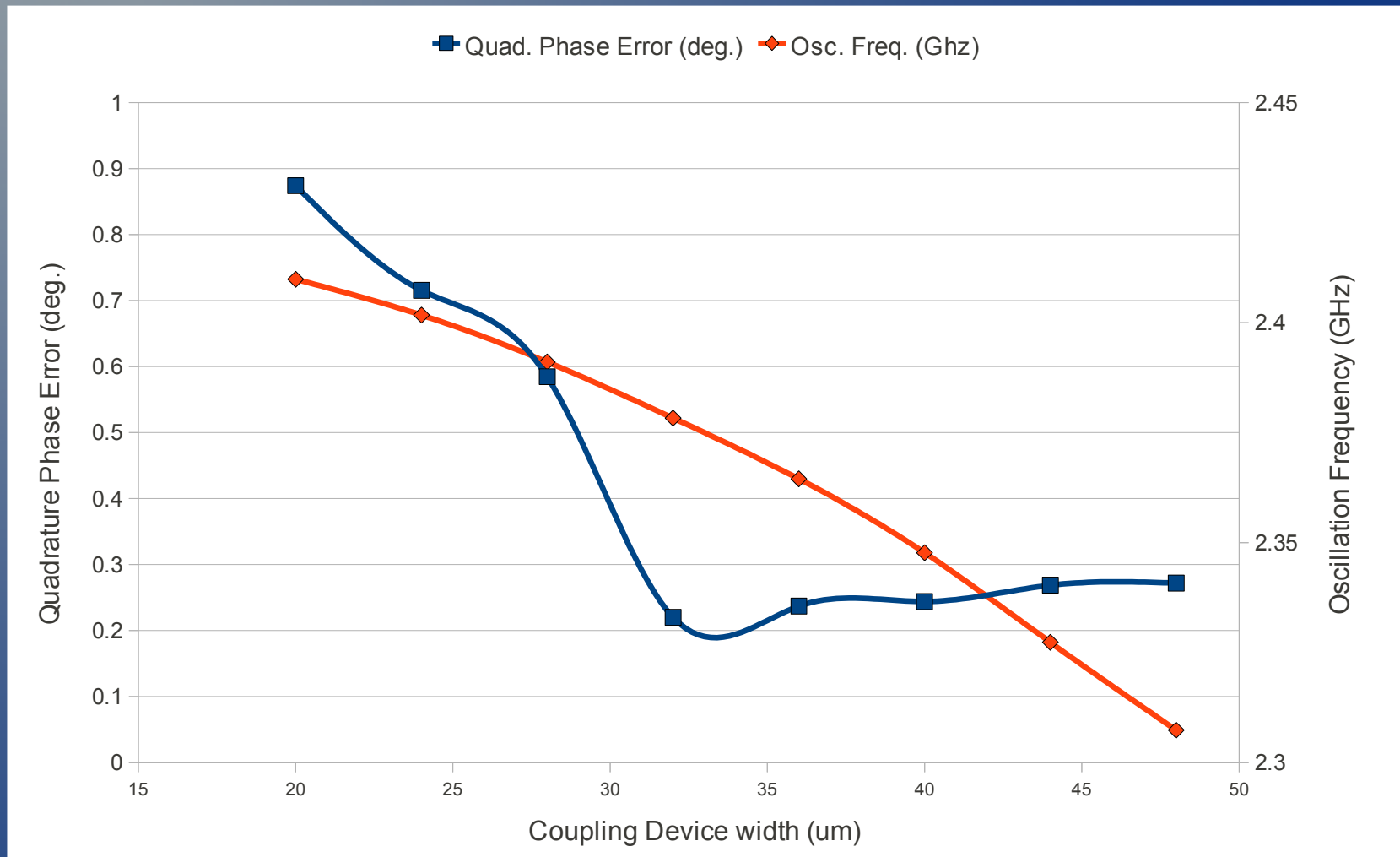


# Shunt QRXO – Phase Noise



- -99.4dBc/Hz @ 1MHz offset
- $R = 24\%$ ;  $M_{5-8}$  (flicker) = 21%;  $M_{1-4}$  (thermal) = 18%

# Shunt QRXO – Phase Error



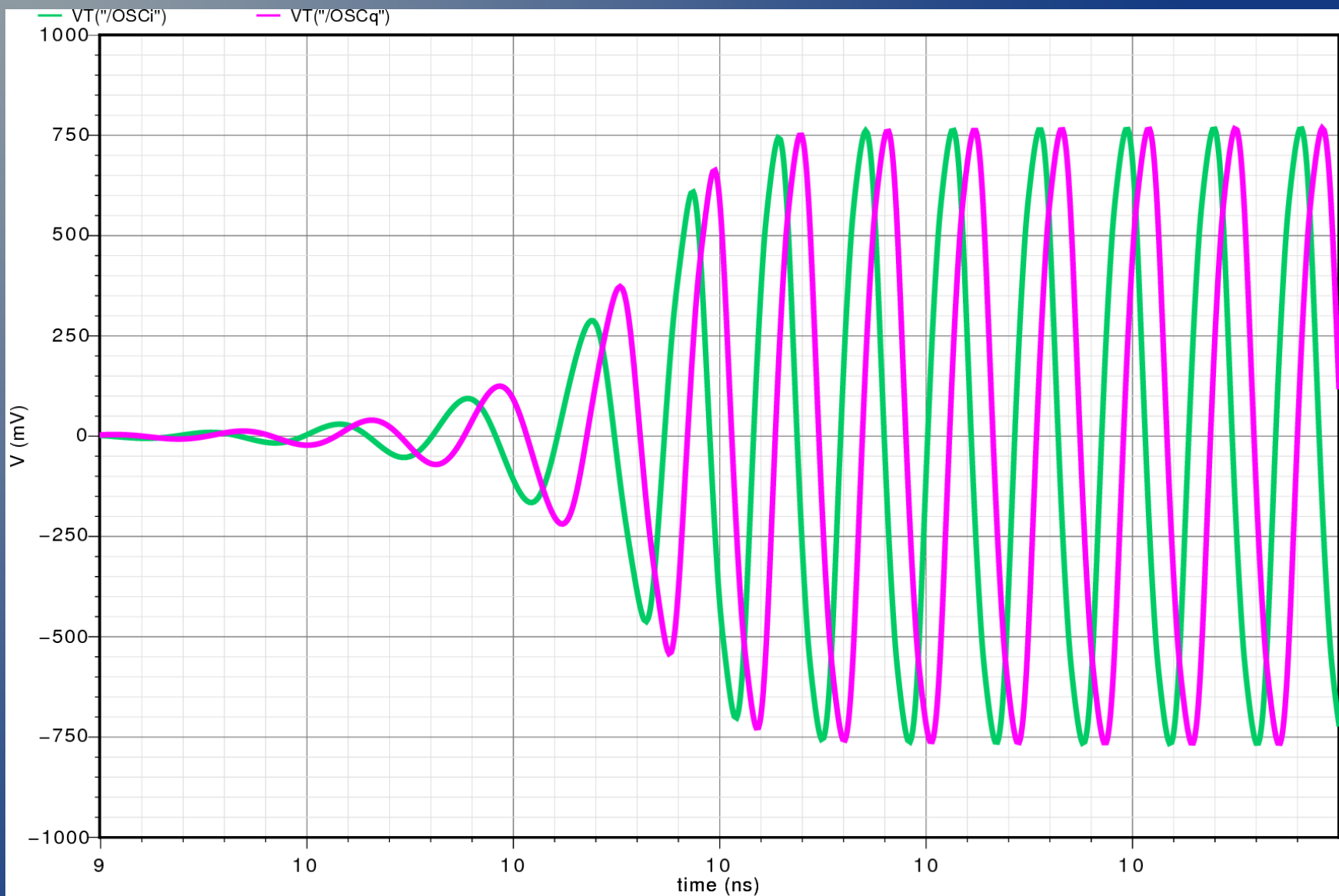


# Series-coupled QRXO

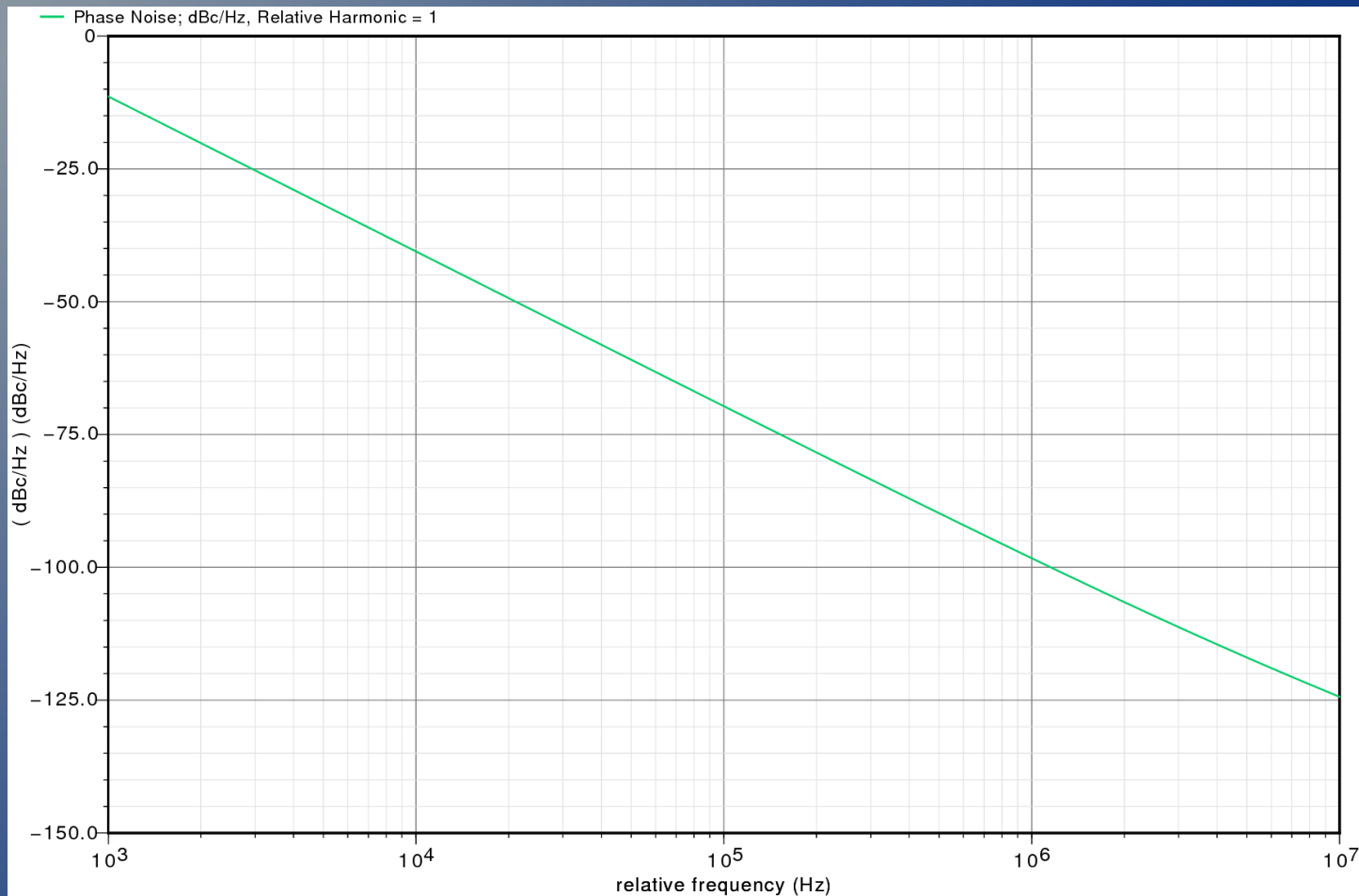
- Quadrature coupling validated in simulation
- Coupling devices
  - Operate in triode region
  - Weaken cross-coupled NMOS operation (degeneration)
  - Large W/L ( $M_{5-8} = 200\mu\text{m} \times 0.18\mu\text{m}$ )
  - Flicker noise less of a concern
- Total QRXO current = 16mA
- 1% I-Q mismatch  $\Rightarrow 0.1^\circ$  quadrature error



# Series QRXO – Startup

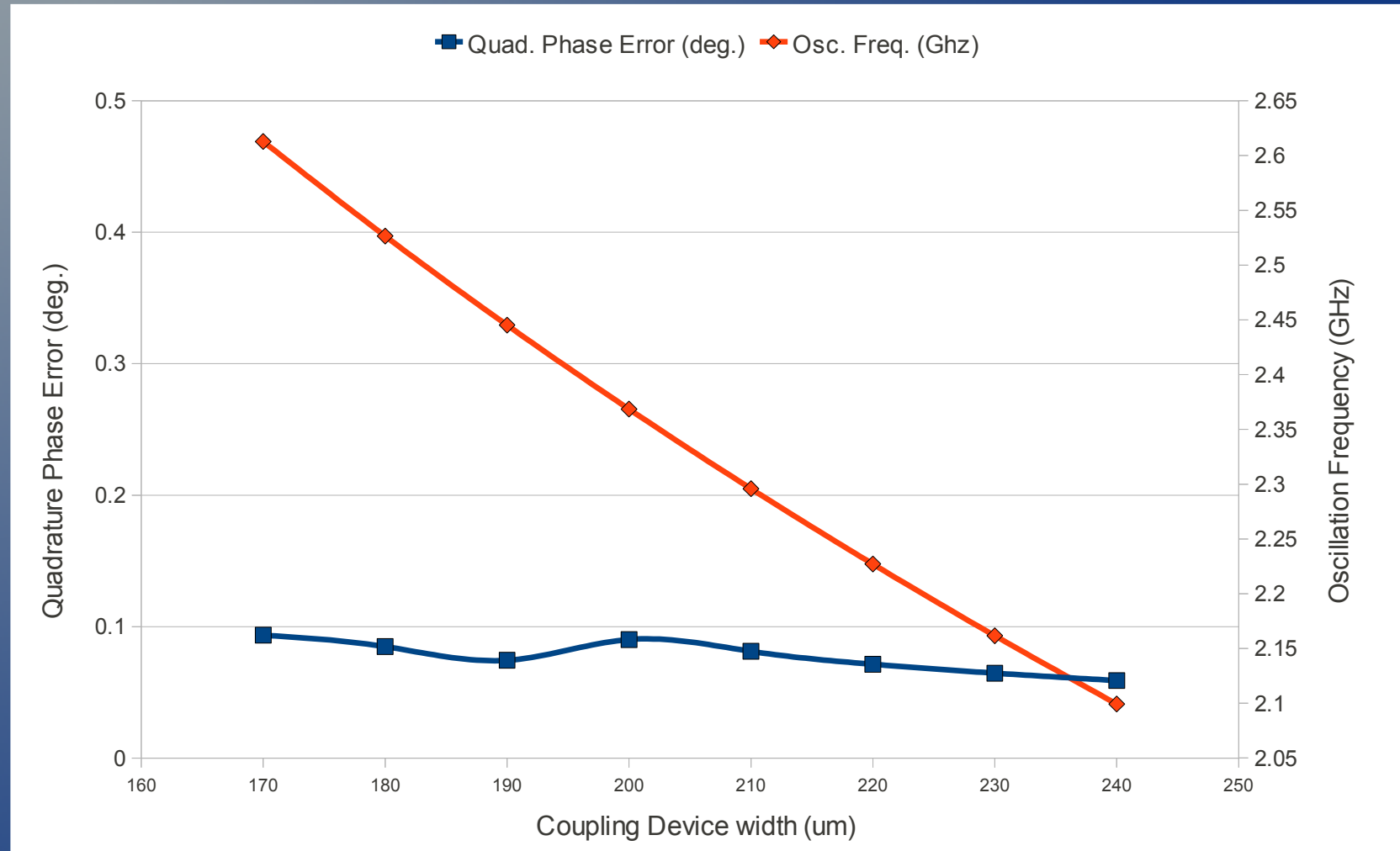


# Series QRXO – Phase Noise



- -98.3 dBc/Hz @ 1MHz offset
- $M_{1-4}$  (flicker) = 70%

# Series QRXO – Phase Error





# Comparison

	Shunt coupled QRXO	Series coupled QRXO
Coupling Devices	Saturation (smaller)	Triode (larger)
Quadrature Error	×	✓
Phase Noise	✓	×
Current Consumption	✓	×



# Summary

- Two topologies for quadrature coupling of relaxation oscillators were presented
- 2.4GHz quadrature oscillators were designed and simulated in a UMC 0.18 $\mu\text{m}$  CMOS process
  - Shunt-coupled  $\Rightarrow$  lower current, larger quadrature error
  - Series-coupled  $\Rightarrow$  larger current, lower quadrature error



# References

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Thank you